

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/645,672	TAKAHASHI ET AL.	
				Examiner	Art Unit	
				Sherali Ishrat	2621	

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✓pdate SEARCH → 11/21/06 IS			
✓pdate SEARCH 5/21/07			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, IEEE	5/12/2005	IS
✓pdate East 6/17/06 IEEE	6/17/06	IS
✓pdated East 11/21/06 IEEE	11/21/06	IS
✓pdated East 5/21/07 IEEE	5/21/07	IS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner